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| APPLICATION NO. | FI | LING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO. | |
|----------------------|----------|----------------|----------------------|---------------------|------------------|--|
| 09/964,735 | • | 09/28/2001 | Shuya Ogi | N36-135856M/TH | 2177 | |
| 30743 | 7590 | 02/10/2004 | | EXAM | EXAMINER | |
| WHITHA | M, CURT | IS & CHRISTOFF | STULTZ, J | STULTZ, JESSICA T | | |
| 11491 SUN | SET HILL | S ROAD | | ART UNIT | PAPER NUMBER | |
| SUITE 340 RESTON. | VA 20190 |) | | 2873 | | |

DATE MAILED: 02/10/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

| | | | | - NO | | | |
|---|---|---|--|--|--|--|--|
| - | | Application No. | Applicant(s) | | | | |
| | | 09/964,735 | OGI ET AL. | | | | |
| | Office Action Summary | Examin r | Art Unit | <u> </u> | | | |
| | | Jessica T Stultz | 2873 | <u>. </u> | | | |
| Period fo | The MAILING DATE of this communication apported to the second section apported to the second seco | pears on the cover sheet with the c | orrespondenc address: | - | | | |
| THE - Exte after - If the - If NO - Failt Any | ORTENED STATUTORY PERIOD FOR REPL MAILING DATE OF THIS COMMUNICATION. nsions of time may be available under the provisions of 37 CFR 1.1 SIX (6) MONTHS from the mailing date of this communication. e period for reply specified above is less than thirty (30) days, a repl period for reply is specified above, the maximum statutory period are to reply within the set or extended period for reply will, by statute reply received by the Office later than three months after the mailined patent term adjustment. See 37 CFR 1.704(b). | I36(a). In no event, however, may a reply be tirely within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from the cause the application to become ABANDONE | nely filed s will be considered timely. the mailing date of this communic D (35 U.S.C. § 133). | cation. | | | |
| Status | | | | 1 | | | |
| 1)⊠ | Responsive to communication(s) filed on 13 J | anuary 2004. | | : | | | |
| · | This action is FINAL. 2b)⊠ This action is non-final. | | | | | | |
| 3)□ | | | | | | | |
| | closed in accordance with the practice under I | Ex parte Quayle, 1935 C.D. 11, 4 | 53 O.G. 213. | | | | |
| Disposit | ion of Claims | | | ÷ | | | |
| · · | Claim(s) 25-35 is/are pending in the application | In | | | | | |
| 1)(2) | 4a) Of the above claim(s) is/are withdra | | | : | | | |
| 5)[7] | Claim(s) is/are allowed. | | | : | | | |
| · · · · · · · · · · · · · · · · · · · | Claim(s) <u>25-35</u> is/are rejected. | | | : | | | |
| 7) | Claim(s) is/are objected to. | | | ; | | | |
| 8)[| Claim(s) are subject to restriction and/o | or election requirement. | | • | | | |
| Applicat | ion Papers | | | | | | |
| 9) | The specification is objected to by the Examine | er. | | : | | | |
| • | 10) ☐ The drawing(s) filed on <u>07 November 2001</u> is/are: a) ☐ accepted or b) ☐ objected to by the Examiner. Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a). | | | | | | |
| | Replacement drawing sheet(s) including the correct | | | 21(d). | | | |
| 11) | The oath or declaration is objected to by the E | xaminer. Note the attached Office | Action or form PTO-15 | 2. | | | |
| Priority | under 35 U.S.C. § 119 | | | | | | |
| _ | • | a priority under 35 LLS C & 110/a | \ (d\ or (f) | t | | | |
| 12)⊠ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a)⊠ All b)□ Some * c)□ None of: | | | | | | | |
| 1.⊠ Certified copies of the priority documents have been received. | | | | | | | |
| | 2. Certified copies of the priority document | | ion No | | | | |
| | 3. Copies of the certified copies of the price | | | · ອ | | | |
| | application from the International Burea | u (PCT Rule 17.2(a)). | | | | | |
| * (| See the attached detailed Office action for a list | of the certified copies not receive | ed. | | | | |
| | | | | | | | |
| Attachmer | nt(s) ce of References Cited (PTO-892) | 4) 🔲 Interview Summary | (PTO-413) | | | | |
| | ce of References Cited (P10-692) ce of Draftsperson's Patent Drawing Review (PT0-948) | Paper No(s)/Mail D | ate | | | | |
| | mation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) er No(s)/Mail Date | 5) Notice of Informal F 6) Other: | Patent Application (PTO-152) | | | | |

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DETAILED ACTION

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 25-26, 29-31, and 34-35 are rejected under 35 U.S.C. 102(b) as being anticipated by Murano et al Japanese document number 06-252450.

Regarding claim 25, Murano et al discloses a rod lens array including at least one rod lens having a center-line average roughness of 0.5 μm- 2.0 μm on the peripheral surface (Abstract and Section 14, wherein the average surface roughness of front face "16" of rod lens "4", ranges between 0.5-5 μm, and wherein lens "4" is part of lens array "2", Figures 2 and 3).

Regarding claim 26, it is inherent from Murano et al that the rod lens array comprises rod lenses such that values for the center-line-average roughness on the peripheral surfaces are between 0.5 µm- 2.0 µm as average for the whole lens array, this being reasonably based upon one of the rod lenses being disclosed as having an average roughness on its peripheral surface falling in this range and the drawings showing that all of the rod lenses have similar structure (Abstract and Section 14, wherein the average surface roughness of front face "16" of lens "4", ranges between 0.5-5 µm, and wherein lens "4" is part of lens array "2", Figures 2 and 3).

Regarding claim 29, it is inherent from Murano et al that the rod lens array disclosed above would further include the representative values for the center-line average roughness be a value on a straight line that extends on the peripheral surface of the lens parallel to it s axis, this

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being reasonably based upon the description of the average surface roughness of the face "16" and Figure 2 (Section 14).

Regarding claim 30, it is inherent from Murano et al that the rod lens array disclosed above would further include the representative values for the center-line average roughness are each the average of values on different straight lines that extend on the peripheral surface of the lens along its axis, this being reasonably based upon the similarity in structure between the drawings of the reference and the claimed invention and since values can be taken along different straight lines across the rod and then averaged to obtain an accurate representation of the entire rod (Figures 2 and 3).

Regarding claim 31, Murano et al further discloses a rod lens array including wherein each of the rod lenses have a center-line average roughness of 0.5 μ m- 2.0 μ m on the peripheral surface (Abstract and Section 14, wherein the average surface roughness of front face "16" of lens "4", ranges between 0.5-5 μ m, and wherein lenses "4" are part of lens array "2", Figures 2 and 3).

Regarding claim 34, Murano et al further discloses a rod lens array wherein a resin portion that is integral with the constituent rod lenses such that it fills the gap between adjacent rod lenses and surrounds all rod lenses (Section 15, wherein the lens "4" is covered with resin "18", Figure 3).

Regarding claim 35, Murano et al further discloses a rod lens array wherein a frame is fixed to at least one of two opposite surfaces of the resin portion such that the frame is parallel with the rod lenses (Section 12, wherein the frame comprises side plate "6" and frame "8", which are parallel to the rod lenses "4", Figure 3).

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Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 27-28 and 32-33 are rejected under 35 U.S.C. 103(a) as being unpatentable over Murano et al.

Regarding claims 27-28 and 32-33, it would have been obvious from Murano et al that the rod lens array comprise center-line-average roughness of the peripheral surfaces of constituent rod lenses have a standard deviation between 0.01 µm to 0.2 µm and the diameters of the rod lenses have a standard deviation between 0.01 µm to 2.5 µm for the whole lens array since Murano et al discloses a rod lens array including at least one rod lens having a center-line average roughness of 0.5 µm- 2.0 µm on the peripheral surface and a diameter of 1.1 mm, wherein the lens rods are very similar in structure (Abstract and Sections 14, wherein the average surface roughness of front face "16" of lens "4", ranges between 0.5-5 µm, and wherein lens "4" is part of lens array "2" and the diameter of lens "4" is 1.1 mm, Figures 2 and 3), therefore the standard deviation between the lens rods should be very small since it is well known in the art of statistical data collection for the standard deviation of values to be small when the lenses are very similar in structure (Figure 3). Therefore it would have been obvious for the rod lens array of Murano et al to further include the center-line-average roughness of the peripheral surfaces of constituent rod lenses have a standard deviation between 0.01 µm to 0.2 µm for the whole lens array since Murano et al discloses a rod lens array including at least one rod lens having a centerApplication/Control Number: 09/964,735

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line average roughness of $0.5 \mu m$ - $2.0 \mu m$ on the peripheral surface wherein the lens rods are very similar in structure, therefore the standard deviation between the lens rods should be very small since it is well known in the art of statistical data collection for the standard deviation of values to be small when the lenses are very similar in structure.

Response to Arguments

Applicant's arguments, see Response, filed January 16, 2004, with respect to the rejection(s) of claim(s) 25-35 under USC 102/103 have been fully considered and are persuasive. Therefore, the previous final rejection has been withdrawn. However, upon further consideration, a new ground(s) of rejection is made in view of Murano et al.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jessica T Stultz whose telephone number is (571) 272-2339. The examiner can normally be reached on M-F 8-4:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Georgia Epps can be reached on 571-272-2328. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

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Jessica Stultz Patent Examiner AU 2873

February 2, 2004

JORDAN SCHWARTZ PRIMARY EXAMINER